

Search Notes

Application/Control No.

10/725,325

Examiner

Steven Loke

Applicant(s)/Patent under
Reexamination

HSHIEH ET AL.

Art Unit

2811

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-------------------------------|------------|----------|
| 257 | 341, 342, 329, 330, 331 | 5/13/2004 | SL |
| 438 | 212, 259 | 5/13/2004 | SL |
| 438 | 270, 271 | 5/13/2004 | SL |
| 438 | 589, 588 | 5/13/2004 | SL |
| 438 | 587 | 5/13/2004 | SL |
| above | updated | 11/18/2004 | SL |
| above | updated | 9/5/2005 | SL |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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